Form P1	ΓO-1449/				750	ATTORNEY DO	OCKET NO.: MAT-0002	APPLICATIO 10/665,583	N NO.:
INFORMATION DISCLOSURE APPLICANT: Stephen POLEDNA STATEMENT BY APPLICANT									
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*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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